

Notice of References Cited	Application/Control No. 10/574,580	Applicant(s)/Patent Under Reexamination KAWATO ET AL.	
	Examiner Hai Vo	Art Unit 1771	Page 1 of 1

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*	B	US-2004/0043234	03-2004	Hay et al.	428/496
*	C	US-6,703,139	03-2004	Ogawa et al.	428/500
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NON-PATENT DOCUMENTS

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